

PATENT NUMBER and
ISSUE DATE

U.S. UTILITY Patent Application

APPL NUM 10053818	FILING DATE 01/22/2002	CLASS 324	SUBCLASS 754	GAU 229 2302	EXAMINER NGUYEN, VINH
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**APPLICANTS: Degani Yaron, Gao Charley, Ta, King

2/24
**CONTINUING DATA VERIFIED:

** FOREIGN APPLICATIONS VERIFIED:

PG-PUB	DO NOT PUBLISH <input type="checkbox"/>	RESCIND <input type="checkbox"/>	ATTORNEY DOCKET NO
Foreign priority claimed		<input type="checkbox"/> yes <input type="checkbox"/> no	
35 USC 119 conditions met		<input type="checkbox"/> yes <input type="checkbox"/> no	S1
Verified and Acknowledged Examiner's initials			
TITLE : Testing integrated circuits			

NOTICE OF ALLOWANCE MAILED		CLAIMS ALLOWED	
		Assistant Examiner	
ISSUE FEE		Primary Examiner	
Amount Due	Date Paid	Total Claims	Print Claim for O.G
TERMINAL DISCLAIMER		DRAWING	
		Sheets Drwg.	Figs.Drwg.
		Print Fig.	
		Application Examiner	
PREPARED FOR ISSUE			
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